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Probing Charge Carrier Dynamics to Unveil the Role of Surface Ligands in HgTe Narrow Band Gap Nanocrystals

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Abstract: Colloidal nanocrystals are an interesting platform for the design of low cost optoelectronic devices especially in the infrared range of wavelengths. Mercury chalcogenides have reached high maturity to address wavelengths above the telecom range (1.5μ m). However, no screening of the surface chemistry influence has been conducted yet. In this paper, we systematically probe the influence of a series of ligands: Cl⁻, SCN⁻, 1,2 ethanedithiol, 1,4 benzenedithiol, 1 octanethiol, 1 butanethiol, As₂S₃, S²⁻ on the photoconductive properties of HgTe nanocrystal thin films. A high bandwidth, large dynamic transient photocurrent setup is used to determine the photocarrier dynamics. Two regimes are clearly identified. At early stage (few ns) a fast decay of the photocurrent is resulting from recombination and trapping. Then transport enters in a multiple trapping regime where carriers present a continuously decreasing effective value of their mobility. The power law dependence of the conductance can be used to estimate the trap carrier density and determine the value of the Urbach energy (35 to 50 meV). We demonstrate that a proper choice of ligand is necessary for a trade-off between the material performance (μ t product) and the quality of the surface passivation (to keep a low Urbach energy).

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INTRODUCTION

Colloidal quantum dots (CQD) are promising candidates for the emergence of low cost optoelectronic devices¹. This is especially true in the infrared range of wavelengths where current technologies remain driven by epitaxially grown semiconductors of II-VI (HgCdTe) and III-V materials. CQD by combining (*i*) the lack of constrain of an epitaxial growth, (*ii*) an ease of processing similar to organic electronics and (*iii*) a strong tunability of the optical absorption from UV to THz² offer a unique platform to revisit infrared optoelectronics³.

To reach wavelengths in the infrared range and especially in the short wavelength infrared range (SWIR) and mid wave infrared range (MWIR⁴), narrow band gap materials have to be used⁵. Among potential candidates, mercury chalcogenides (HgS^{6,7}, HgSe⁸⁻¹⁰ and HgTe¹¹) are the most mature materials, combining a tunable infrared absorption^{12,13} with photoconductive¹⁴ properties. In spite of huge progresses reported over the past decades¹⁵, which include the report of photovoltaic devices¹⁶, intraband transition based photodetector^{1,17}, plasmonic devices^{18,19} and multicolor devices^{20,21}, no rational design of the material has been conducted. As a result, very little is known²² about the electronic structure of these narrow band gap confined CQD. Particularly, no screening of the surface chemistry influence has been reported yet in contrast to what has been reported for PbS CQD²³ for example.

In a photoconductor, the product of the mobility (μ) by the lifetime (τ) is driving the value of the photocurrent magnitude²⁴. While DC photocurrent measurements give access to the product $\mu \cdot \tau$, accessing separately to these two parameters is more challenging. To do so, we use a combination of field effect transistor measurements and transient photocurrent measurements to extract respectively the mobility and carrier lifetime. Our time resolved measurements, conducted over 6 orders of magnitude of duration, exhibit two different regimes. At short time scale the carrier population quickly thermalizes and is followed by a long tail power law behavior, which results from a multi trapping transport process. From the latter, we are able to extract the Urbach energy which describes the trap state distribution. Finally using X-ray photoemission we are able to propose a full electronic spectrum of the quantum and trap states in absolute energy scale.

METHODS

1. Chemicals

Mercury chloride (HgCl₂, Strem Chemicals, 99%), tellurium powder (Te, Sigma-Aldrich, 99.99%), trioctylphosphine (TOP, Cytek, 90%), oleylamine (Acros, 80-90%), 1,octanethiol (OSH, Fluka), 1,butanthiol (BuSH, Sigma Aldrich), benzedithiol (BeSH, Alfa), dodecanethiol (DDT, Sigma-Aldrich, 98%), sodium sulfide nonahydrate (Na₂S,9H₂O, Sigma Aldrich, 98.0%), arsenic trisulfide (As₂S₃, Alfa Aesar, 99.9%), 1,2,ethanedithiol (EDT, Fluka, 98.0%), ammonium chloride (NH₄Cl, Sigma Aldrich), ammonium thiocyanate (NH₄SCN, Sigma Aldrich), butylamine (Sigma Aldrich), hydrochloric acid (HCl, Mieuxa, 25%), lithium perchlorate (LiClO₄, Sigma-Aldrich, 98%), polyethylene glycol (PEG, M_w = 6 kg.mol⁻¹), chloroform (Carlo Erba), ethanol absolute anhydrous (Carlo Erba, 99.9%), methanol (Carlo Erba, 99.8%), acetone (Carlo Erba, 99.8%), n-hexane (Carlo Erba), n-octane (SDS, 99%), toluene (Carlo Erba, 99.3%), N-methylformamide (NMF, VWR, 98%) . All chemical are used as received, except oleylamine which is centrifuged before used. **Mercury compounds are highly toxic. Handle them with special care.**

2. Material synthesis

1 M TOPTe precursor: 2.54 g of Te powder are mixed in 20 mL of TOP in a three neck flask. The flask is put under vacuum at room temperature for 5 min and then the temperature is raised at 100°C and the degassing is further conducted over the next 20 minutes. The atmosphere is then switched to Ar and the temperature raised to 275°C. The solution is stirred until a clear orange solution is obtained. The flask is then cooled down and the color switches

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to yellow. At room temperature, the flask is degassed again for 10 min. Finally, this solution is transferred to an air free glove box for storage.

HgTe synthesis: In a 25 mL three neck flask, 135 mg of HgCl₂ and 15 mL of oleylamine are degassed at 110°C for 1 h. Under Ar at 80°C, a solution containing 0.5 mL of 1 M TOPTe and 4.5 mL of oleylamine is quickly injected. The reaction is conducted for 3 minutes. The reaction is quenched by a mixture of chloroform (15 mL), DDT (1.5 mL) and TOP (several drops) and the flask is cooled down using fresh air. The particles are precipitated in ethanol and dispersed in toluene or 9:1 hexane-octane depending on the ligand-exchange procedure.

Ligand exchange procedures

On film procedure: Solution of HgTe nanoparticles in 9:1 hexane-octane is dropcasted on a clean substrate. Once the solvent is completely evaporated, ligand exchange is performed on the sample to remove DDT and replace it by OSH, BuSH, BeSH, EDT, S^{2-} , Cl⁻, SCN⁻ or As₂S₃. These ligands are simply dissolved in ethanol to reach a 1 wt% solution, except for As₂S₃ which is first dissolved in butylamine before a few drops of this solution are mixed to about 20 mL of ethanol. To perform ligand exchange, the film is dipped into the solution containing the new ligands for 90 s. Then the film is rinsed with ethanol for 30 s. To get a thicker film (around 100 nm at the end), this step can be repeated 3 to 5 times.

Liquid phase procedure: 0.5 mL of a concentrated solution of Na₂S in NMF is poured into a solution of HgTe nanoparticles in toluene (about 2 mL). 1 mL of hexane is added to help phase dissociation and the mixture is sonicated. The particles migrate from the apolar phase (toluene+hexane) down to the polar phase (NMF) by exchanging their ligands. The upper phase is removed and the NMF phase is washed 3 times with hexane. Then, 2 mL of ethanol and 2 mL of toluene are poured into the NMF solution to destabilize the particles and help them flocculating. The solution is then centrifuged at 3300 rpm for 3 min and the particles are dispersed in fresh NMF (a few milliliters). This liquid phase ligand exchange procedure can also be done with As₂S₃, the Na₂S in NMF solution is then replaced by 0.5 mL of a saturated solution of As₂S₃ in butylamine, diluted in 0.5 mL of NMF. In this case the films are obtained by dropcasting the solution onto the electrodes on a hot plate (100°C).

Electrodes fabrication

Si/SiO₂ substrate for electrodes: The surface of a Si/SiO₂ wafer (400 nm oxide layer) is cleaned by sonication in acetone. The wafer is rinsed with isopropanol and finally cleaned using an O₂ plasma. AZ 5214E resist is spin-coated and baked at 110°C for 90 s. The substrate is exposed under UV through a pattern mask for 2 s. The film is further baked at 125°C for 2 min to invert the resist. Then a 40 s flood exposure is performed. The resist is developed using a bath of AZ 326 for 32 s, before being rinsed in pure water. We then deposit a 5 nm chromium layer and 80 nm gold layer using a thermal evaporator. The lift-off is performed by dipping the film in acetone for 1 h. The electrodes are finally rinsed using isopropanol and dried by an air flow. The electrodes are 2.5 mm long and spaced by 20 µm. These electrodes are used for DC measurements (IV curves and transistor measurements).

PET/ITO electrodes: The surface of a PET/ITO wafer is cleaned by rinsing with acetone and isopropanol. AZ 5214E resist is spin-coated and baked at 110°C for 90 s. The substrate is exposed under UV through a pattern mask for 4 s. The resist is developed using a bath of AZ 326 for 45 s, before being rinsed in pure water. We then proceed to the etching of the electrodes by dipping the substrate in 25% HCl for 10 s and rince with pure water to quench. The electrodes are finally rinsed using isopropanol and dried by an air flow. The electrodes are 1 mm long and spaced by 20 μ m. These electrodes are used for transient photocurrent measurements. Transparent electrodes are used to avoid any heating effect of the photoresponse which tends to introduce drift.

Electrolyte gating: For electrolyte gating we first mix in a glove box 0.5 g of $LiClO_4$ with 2.3 g of PEG (M_w = 6 kg.mol⁻¹). The vial is heated at 170°C on a hot plate for 2 h until the solution gets clear. To use the electrolyte, the solution is warmed around 100°C and brushed on the top of the HgTe film. ACS Paragon Plus Environment

Electrical measurements

DC transport: The sample is connected to a Keithley 2634b which controls the drain bias (V_{DS}) between -2 and +2 V with a step of 10 mV, and measures the associated current (I_{DS}). This measurement is made in the dark and under illumination (green diode, 532 nm, 25 mW).

Transistor measurements: The sample is connected to a Keithley 2634b which sets the drain bias ($V_{DS} = 0.01 V$), controls the gate bias (V_{GS}) between -2 and +2 V with a step of 1 mV and measures the associated currents I_{DS} and I_{GS} . The measurements are repeated 5 times to ensure the obtained curves are stable.

Time – resolved measurements: For the time-resolved measurements, we use a pulsed laser (Crylas FTSS 355-50) at 355 nm. The laser beam is around 1 mm in diameter (*ie* poorly focused) to prevent excessive heating of the sample, which may lead to a drift of the photoresponse. The pulses are 1 ns long and repeated every 10 ms (100 Hz). A photodiode is used to trigger the signal. The sample is placed in a vacuum chamber and connected as shown in Figure 3a. The bias, 50 V, is applied by a Keithley 2432b. An oscilloscope (Rohde & Schwarz, RTE 1102) acquires the outcoming signal through a 50 Ω resistor, which is proportional to I_{DS}. The response of the film is measured at different time scales, normalized, and plot in a log-log plot as shown on Figure 3b.

DISCUSSION

We first synthetize DDT capped HgTe CQD with an excitonic feature at 4000 cm⁻¹ (\approx 0.48 eV of band gap or 2.5 µm, see Figure 1a), using previously reported procedure²⁵. The absorption cut off wavelength of this material is well suited for the detection of short wave infrared wavelengths, which is motivated by the possibility to conduct infrared imaging thanks to night glows. The material presents a tetrapodic shape, see transmission electron image in Figure 1b and has a zinc blende structure²⁵.



Figure 1 a. Infrared spectrum of HgTe CQD capped with dodecanethiol (DDT) and ethanedithiol (EDT). b. TEM image of the used HgTe CQD with a tetrapodic shape.

To make the material suitable for the design of infrared detectors, it is critical to exchange the initial long and insulating capping ligands (dodecanethiol) for shorter molecules, which will ensure a better interdot electronic coupling and an increase of the conductivity. We have selected a series of short ligands, which have been tested on

nanocrystals to improve the charge transport and phototransport properties of films: Cl⁻²⁶, SCN⁻²⁷, ethanedithiol (EDT)²⁸, S²⁻²⁹, As₂S₃^{28,30}. In addition we tested a series of thiol ligands with different chain length to address the effect of the inter CQD distance on the photoresponse, these ligands are octanethiol (OSH), butanethiol (BuSH) and benzendithiol (BeSH). For OSH, BuSH, BeSH, Cl⁻, SCN⁻ and EDT, the ligand exchange is conducted on film by dipping the film in a solution of short ligands in excess. For S²⁻ and As₂S₃ we have tested both on film and in solution (*ie* phase transfer²⁴) method. The typical signature of this exchange is a significant reduction of absorption relative to the C-H bond at 3000 cm⁻¹, see Figure 1a. This reduction of the amount of C-H in the film is around 80% in the case of on film ligand exchange and it is complete for the in-solution process. Another important feature of this spectrum is the retaining of quantum confinement in nanocrystals even after ligand exchange.

The film of nanoparticles is then deposited on gold interdigitated electrodes and we follow the dark and under illumination conductance, see Figure 2a. The films of HgTe CQD present an ohmic conduction in the range of applied electric field ($F \approx 1 \text{kV.cm}^{-1}$). Under illumination we observe a positive photoresponse. Figure 2b shows the modulation of the ratio of the conductance under illumination over conduction in the dark. This ratio typically follows a similar trend as detectivity. The general trend is the following: CI < BuSH \approx OSH<SCN < EDT< As₂S₃< S²⁻<BeSH, it appears that ligands binding through the sulfur are more suitable for photoresponse. As expected long thiol chain leads to a lower level of performance than short dithiol (EDT and BeSH) molecules. We also observe that liquid phase ligand exchange tends to increase the dark conductance leading to a smaller light/dark ratio. This effect is partly due to the necessary annealing (at 100°C) of the nanocrystal film to remove the polar solvent which consequently increases the dot size.



Figure 2 a. IV curves of an HgTe CQD film capped with EDT under dark condition in black and under illumination $(\lambda=532 \text{ nm} - P=25 \text{ mW})$ in red. b. Ratio of the conductance under illumination over conductance in the dark for HgTe CQD film capped with different ligands. c. Transfer curve (drain current as a function of gate bias) of an HgTe CQD film capped with EDT ligands and used as a channel of an ion gel gated transistor ($V_{DS} = 10 \text{ mV}$). d. Mobilities of electrons and holes for HgTe CQD films capped with different ligands capped with different ligands normalized by the electronic mobility of EDT

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capped HgTe CQD. Error bars have been determined by repeating the measurement for each samples at least three times.

The photocurrent magnitude is driven by the product of the mobility by the time, and this product can be easily obtained with DC measurements. To go further in the understanding of these materials, we want to determine the contribution of each factor and so, to measure independently these two quantities. The mobility of thin films is easy to access through field effect transistor measurements³. To do so, we build an ion gel gated transistor, where the film of HgTe CQD is connected to a quasi-solid electrolytic gate³¹. The latter combines several advantages: (i) it is air operable, (ii) it presents a large gate capacitance, which allows tuning of carrier density up to several carriers per nanocrystal and finally (iii) it is possible to gate thick films, which is critical with in mind the design of strongly absorbing films for photodetection.

HgTe CQD films present an ambipolar behavior where both holes (under negative gate bias) and electrons (under positive gate bias) can contribute to the transport, see Figure 2c. This behavior is the result of the narrow band gap nature of the HgTe CQD with respect to the ability of the electrolyte gating to tune the Fermi level over several hundred meV. We observe that the charge neutrality point (*ie* the bias at which the conduction switches from hole to electron) is systematically at negative bias. This suggests that the initial HgTe CQD are n-doped which will be further discussed in the last part of the article. The derivative of the transfer curve is directly proportional to the carrier mobility, however electrolyte gating is not well suited to extract absolute value of the mobility because the gate capacitance is not accurately known. Nevertheless we can compare the relative mobility obtained for the different capping ligands, see Figure 2d. We systematically observe that the electron mobility is a factor two to three times higher than the hole mobility. Moreover the general trends in term of mobility is quite close to the one observed for photocurrent SCN⁻ OSH<Cl⁻ SuSH<BeSH<EDT< As₂S₃<S²⁻.

To extract the photocarrier lifetime, we build a high bandwidth (GHz) transient photocurrent setup, see Figure 3a for a scheme of the setup. It is common to estimate such lifetime from the time resolved photoluminescence (PL); however this is difficult to conduct on narrow band gap materials for which the PL efficiency is intrinsically low. Moreover, the PL measurement is conducted in very different configuration (*ie* generally in solution or on film without applied electric field) which may introduce significant deviations. The specificity of our setup comes from its ability to probe the dynamics on a broad range of duration, typically from ns to ms. From this configuration, we are able to measure the dynamics on the film under an applied electric field, in order to probe transport dynamics. As a result not only are we able to probe the initial carrier density relaxation but also longer processes including trapping and detrapping. A typical curve of conductance as a function of time is shown in Figure 3b. The curve can be splitted in three main parts. At extremely early time (<ns) we observe a rise of the conductance, which duration follows the laser pulse duration. Then, we observe a fast decay (in the 1 to 10 ns range), this regime can be fitted with a single exponential and the decay time is typically a few ns, see Figure 3c. This time scale can be compared to the hopping time τ_{hop} , the time for a carrier to get transported from one CQD to the next one. From the Einstein relationship we

can evaluate the hopping time: $\tau_{hop} = \frac{2eR^2}{3\mu k_b T}$, with *e* the proton charge, *R* the nanoparticle radius, μ the mobility,

 k_b the Boltzmann constant and T the temperature (300 K). Assuming a mobility of 10^{-3} cm²V⁻¹s⁻¹ from previous report,²⁷ we estimate the hopping time to be ≈ 3 ns. Since the early decay that is observed occurs at a time scale shorter than the hopping time, it results from a change of carrier density at the nanocrystal scale rather than a change of number of carriers due to transport from one nanocrystal to another. Gao *et al* in a recent investigation of the photocurrent dynamics at very short time scale (ps to few ns) arrived at the same conclusion^{32,33}. Thus the observed decay rate is the combination of two processes: (*i*) an interband bimolecular recombination of photogenerated electron hole pair with a decay rate k_{inter}^{rec} and (*ii*) a carrier trapping with dynamics described by k_{traps}^{rec} . From this lifetime, we are able to estimate the mobility lifetime product. To take into account both the electron and hole mobilities, we actually evaluate the quantity $\sqrt{\mu_e \cdot \mu_h} \cdot \tau$, see Figure 3c. The obtained ordering of the ligand is actually very well correlated with the photoresponsivity measurement, with clearly lower performance ACS Paragon Plus Environment

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from long thiols (OSH, BuSH), SCN⁻ and Cl⁻, intermediate performance for EDT and BeSH and higher performances for the two exchanges which are S²⁻ on film and As₂S₃ in solution. Overall a good agreement is obtained between photoconductive signal G_{light}/G_{dark} and the $\sqrt{\mu_e \cdot \mu_h} \cdot \tau$ product, except in the case of BeSH which photoresponse is better than predicted by the mobility lifetime product. This might result from a decrease of the dark current which can be associated to a shift of the band with respect to the Fermi level. The latter leads to a change of doping and to the dark current value, as recently highlighted in the case of PbS²³ and HgSe³⁴ CQDs.



Figure 3a. Scheme of the transient photocurrent setup. b. Typical conductance curve for a film of EDT capped HgTe CQD as a function of time after its illumination by a 1 ns pulse of light at 355 nm. c. Exciton lifetime, obtained while fitting the short time scale part of the temporal dependence of the conductance, and its product with mobility for HgTe CQD film capped with different ligands. d. Value of the exponent obtained while fitting the long time scale part of the conductance and the value of the Urbach energy for HgTe CQD film capped with different ligands.

At longer time scale, from 10 ns up to several ms, the curve follows a power law and no characteristic time scale (in particular no transit time) can be extracted, see Figure 3b. The exponent value ($G \propto t^b$) relating the conductance to the decay duration is typically between -0.25 and -0.6 depending on the ligands, see Figure 3d. The power law dependence of the transient photocurrent has been extensively studied in the mid 80's in the context of amorphous and insulating materials³⁵. As₂Se₃ is probably the most investigated material^{36,37}. The presence of this power law dynamics has been interpreted in term of multi trapping transport. After illumination of the sample, carriers get

trapped in a tail of the density of states and they present a null mobility until they get thermally re-excited above the mobility band edge. In this regime the number of carriers is constant and the time that they spend on the trapped state makes them behaving as they were continuously decelerated³⁵.

Let's assume an exponentially decreasing tail of the density of states for the trap distribution. The characteristic energy decay of this density of states is called Urbach energy E_U^{38} . It is possible to relate the power law exponent of

the time dependence of the conductance to the value of the Urbach energy through the relation: $b = -1 + \frac{k_b T}{E_{tr}}$. As

a result, it is possible to determine the density of trap states from this transient photocurrent measurement. It is an important experimental result because other methods to probe the density such as the measurement of the subband-gap absorption using thermal spectroscopy³⁸ are difficult to adapt in the infrared range due to the lower dynamics of the spectrometer. We estimate the Urbach energy to range from 35 meV to 60 meV. In the case of S²⁻, we can observe that liquid phase ligand exchange is leading to a higher Urbach energy. A large Urbach energy can be extremely detrimental and it is typically at the origin of the low open circuit voltage in CQD based solar cell³⁹. As a result, S²⁻ ligands which may have look promising from a mobility perspective appear to be actually poor candidates due to the large amount of traps. On the other hand, short dithiol (BeSH and EDT) leads to the lowest amount of traps. Thus in spite of their intermediate mobility lifetime product, they are the one that bring the best trap passivation.



Figure 4 a. X-ray photoemission spectrum of the Hg4f state from S^{2-} capped HgTe CQD. b. X-ray photoemission spectrum of the valence band from S^{2-} capped HgTe CQD. c. Reconstructed energy spectrum of S^{2-} capped HgTe CQD. The Fermi level corresponds to 0 eV energy level.

To finish the discussion, we would like to discuss more deeply the exact origin of the trap states. Electron microscopy image (Figure 1b) clearly reveals some size distribution for the CQD. In this case, the large CQD are less confined and may behave as trap states for the small (more confined) CQD. Moreover surface reconstruction and dangling bonds can also generate trap states. To confirm the last hypothesis, we first perform energy-dispersive X-ray measurements which reveal a clear Hg excess in HgTe nanocrystals, with a Hg/Te ratio equal to 1.2 (see Table S1). The excess mercury atoms are localized in surface and get bonded to the ligands which could lead to surface states. Therefore, we use X-Ray photoemission spectroscopy (XPS) and focus on Hg peaks as probe of potential surface states. Measurements have been conducted on the TEMPO beamline of synchrotron SOLEIL. High resolution XPS on the Hg 4f peak reveals the presence of two states, see Figure 4a, while the Te, with no excess in surface, only comes under a single population, see figure S9. The Hg 4f state appears as a doublet with a 4.05 eV spin orbit splitting. After removing the background and fitting the curve with a Voigt shape, we clearly distinguish two contributions. The lowest binding energy (BE) peak has an energy of 100.3 eV and a Full Width at Half Maximum (FWHM) of 0.75 eV.

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The second peak presents a 100.8 eV BE with a FWHM of 0.75 eV. The ratio of the two peaks can be changed by tuning the photoelectron escape depth. The higher the incident photon energy (*ie* for large electron escape depth), the smaller the BE peak at higher energies.³⁴ As a result we can attribute the second peak to surface states.

Mercury atoms at the surface get bonded to sulfide based ligands, in contrast to bulk Hg atoms which are bonded to Te. Since sulfur has a higher electronegativity compared to Te, the Hg atoms coupled to sulfur are less electron rich and this shifts the binding energy toward higher values.

A zoom on the low BE part of the XPS spectrum can be used to extract the location of the valence band with respect to the Fermi level. We obtain a value of 0.40 eV, see Figure 4b. Since the band edge energy is 0.48 eV, we conclude that the Fermi level is close to the conduction band (but still in the gap) in this material, this observation being consistent with (*i*) the transistor measurements which systematically present a negative bias for the charge neutrality point and (*ii*) recent electrochemical measurements on n-type HgTe CQD⁴⁰. Finally we propose a reconstructed energy spectrum for the HgTe CQD which include the trap state distribution, see Figure 4c.

CONCLUSION

We have investigated the effect of a series of ligands (Cl⁻, SCN⁻, OSH, BuSH, BeSH, EDT, As₂S₃, S²⁻) on the photoconductive properties of HgTe with in mind the identification of the capping agent leading to the highest mobility by lifetime product. Surface chemistries based on sulfide ligands seem the more promising. We build a high bandwidth transient photocurrent setup and identify two regimes for the photoconduction. At early time, carriers get recombined and trapped. Then a multiple trapping regime of transport is leading to a power law dependence for the photoconductance. From the fitted exponent we are able to extract the value of the Urbach energy which enables us to evaluate the density of trap states in the gap. In particular, we show that liquid phase exchange is leading to more traps than the solid state approach, which will be quite detrimental for the design of device in a photovoltaic configuration. It appears that the choice of ligand is a tradeoff between performances (ie $\mu\tau$ product) and the amount of induced traps and that short dithiol like EDT and BeSH are around the optimal performance for photoconduction. Finally, we determine by using XPS a full energy spectrum where both quantum and trap states can be located in absolute energy scale.

Supporting Informations

The Supporting Information is available free of charge on the ACS Publications website at DOI: Preparation of films, optical properties, transport properties in DC and time resolved configuration and photoemission measurements

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